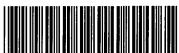
Search Notes



Application/Control	No.
• •	

10/044,646 Examiner

HUNG Q. PHAM

Applicant(s)/Patent under Reexamination

KRISHNA ET AL.

Art Unit

2168

SEARCHED				
Class	Subclass	Date	Examiner	
707	2,3,10,204	3/15/2006	HP	
		·		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
707	2,3,10,	3/15/2006	НР	
	204			

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST SEARCH	3/13/2006	НР
IEEE SEARCH	3/15/2006	HP
ACM SEARCH	3/15/2006	HP